

<b>Notice of References Cited</b>	Application/Control No. 10/040,410	Applicant(s)/Patent Under Reexamination CHEN, YUNG-HSIN	
	Examiner Arrienne M. Lezak	Art Unit 2143	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0123302 A1	06-2004	Lo et al.	719/310
	B	US-6,526,442 B1	02-2003	Stupek et al.	709/224
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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**NON-PATENT DOCUMENTS**

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